

9/26/2003

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Sheet 1 of 1

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M122-2398		PRIORITY SERIAL NO.: 09/798,806	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary) Application #: 10/ 672, 816				APPLICANT: Terry L. Gilton			
				PRIORITY FILING DATE: March 2, 2001		PRIORITY GROUP ART UNIT: 1765	

U.S. PATENT DOCUMENTS							
Examiner's Initials	Class	Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate
BT	AA	5,431,861	07/95	Nagahiro et al.			
BT	AB	5,464,480	11/95	Matthews			
BT	AC	5,776,296	07/98	Matthews			
BT	AD	5,783,790	07/98	Mitsumori et al.			
BT	AE	5,803,956	09/98	Ohmi et al.			
BT	AF	5,944,907	08/99	Ohmi			
BT	AG	6,197,733	03/01	Mikami et al.			
BT	AH	6,273,108	08/01	Bergman et al.			
BT	AI	2001/0037816 A1	11/01	Torek et al.			

FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
	AJ							
	AK							
	AL							

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)			
	AM		
	AN		
	AO		

EXAMINER Binh Tran	DATE CONSIDERED 8/29/05
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449 OTPE JC107 FEB 0 4 2004 PATENT & TRADEMARK OFFICE		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-2398		SERIAL NO. 10/672,816	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT: Micron Technology, Inc.			
				FILING DATE September 26, 2003		GROUP Unknown	

U.S. PATENT DOCUMENTS							
Examiner's Initials	Class	Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate
BT	AA	6,645,874 B1	11/2003	Torek et al.	438	723	
BT	AB	6,267,125 B1	07/2001	Bergman et al.	134	102.1	
BT	AC	6,240,933 B1	06/2001	Bergman	134	1.3	
BT	AD	09/386,247		Torek et al.			08/31/1999
	AE						
	AF						
	AG						
	AH						
	AI						

FOREIGN PATENT DOCUMENTS								
Examiner's Initials	Class	Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)			
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EXAMINER Binh Tran	DATE CONSIDERED 8/29/05
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